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- **EPIC** ™ (Enhanced-Performance Implanted CMOS) 2-µ Process
- Typical V_{OLP} (Output Ground Bounce) $< 0.8 \text{ V at V}_{CC}, T_A = 25^{\circ}\text{C}$
- Typical V_{OHV} (Output V_{OH} Undershoot) > 2 V at V_{CC}, T_A = 25°C
- **ESD Protection Exceeds 2000 V Per** MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JEDEC Standard JESD-17
- **Package Options Include Plastic** Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), Ceramic Flat (W) Packages, Chip Carriers (FK), and (J) 300-mil DIPs

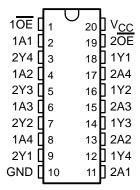
description

These octal buffers/drivers are designed for 2.7-V to 5.5-V V_{CC} operation.

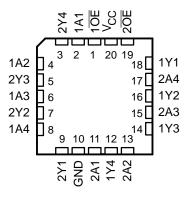
The 'LV240 are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The 'LV240 are organized as two 4-bit buffers/line drivers with separate output-enable (\overline{OE}) inputs. When OE is low, the device passes data from the A inputs to the Y outputs. When \overline{OE} is high, the outputs are in the high-impedance state.

SN54LV240 ... J OR W PACKAGE SN74LV240 . . . DB. DW. OR PW PACKAGE (TOP VIEW)



SN54LV240 . . . FK PACKAGE (TOP VIEW)



The SN74LV240 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54LV240 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74LV240 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each buffer)

INPU	JTS	OUTPUT
OE	Α	Y
L	Н	L
L	L	Н
Н	Χ	Z

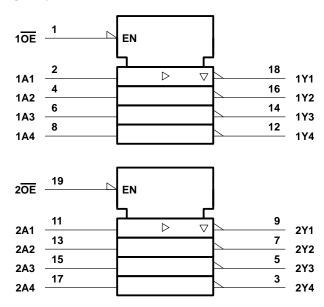


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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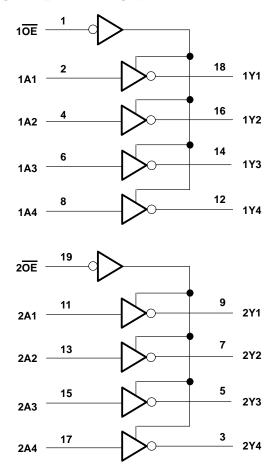
logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for DB, DW, J, PW, and W packages.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, V _O (see Notes 1 and 2)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±35 mA
Continuous current through V _{CC} or GND	±70 mA
Maximum power dissipation at $T_A = 55^{\circ}$ C (in still air) (see Note 3): DB package	e 0.6 W
DW packag	e 1.6 W
PW packag	e 0.7 W
Storage temperature range, T _{stg}	–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 7 V maximum.
 - 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.



recommended operating conditions (see Note 4)

			SN54L	V240	SN74LV240		UNIT	
			MIN	MAX	MIN	MAX	UNII	
Vсс	Supply voltage		2.7	5.5	2.7	5.5	V	
\/	High-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		2		V	
VIH	nigii-ievei iriput voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	3.15		3.15			
VIL	l and land in a straight and	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		0.8	V	
	Low-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		1.65		1.65	V	
VI	Input voltage		0	Vcc	0	VCC	V	
۷o	Output voltage		0,	VCC	0	VCC	V	
	High-level output current	V _{CC} = 2.7 V to 3.6 V	20	-8		-8	A	
ЮН		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	130	-16		-16	mA	
	Low lovel output ourrent	V _{CC} = 2.7 V to 3.6 V	8			8	mA	
IOL	Low-level output current $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$			16		16		
Δt/Δν	Input transition rise or fall rate	-	0	100	0	100	ns/V	
TA	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 4: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	,, ₊	SN54LV240	SN74LV240	LINIT	
PAKAMETEK		v _{cc} †	MIN TYP MAX	MIN TYP MAX	UNIT	
	I _{OH} = -100 μA	MIN to MAX	V _{CC} – 0.2	V _{CC} - 0.2		
Voн	$I_{OH} = -8 \text{ mA}$	3 V	2.4	2.4	V	
	I _{OH} = -16 mA	4.5 V	3.6	3.6		
	I _{OL} = 100 μA	MIN to MAX	0.2	0.2		
V_{OL}	I _{OL} = 8 mA	3 V	0.4	0.4	V	
	I _{OL} = 16 mA	4.5 V	0.55	0.55		
1.	V _I = V _{CC} or GND	3.6 V		±1		
łį		5.5 V	±1	±1	μΑ	
	VO = VCC or GND	3.6 V	±5	±5		
loz		5.5 V	50 ±5	±5	μΑ	
laa	V: V or CND I- 0	3.6 V	20	20		
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V	20	20	μΑ	
ΔICC	One input at V _{CC} – 0.6 V, Other inputs at V _{CC} or GND	3 V to 3.6 V	500	500	μΑ	
C _i	V V OND	3.3 V	3	3	pF	
	$V_I = V_{CC}$ or GND	5 V	3	3		
0	V V - CND	3.3 V	8	8		
Co	$V_O = V_{CC}$ or GND	5 V	8	8	pF	

[†] For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions.

SN54LV240, SN74LV240 OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

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switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER			SN54LV240								
	FROM (INPUT)	TO (OUTPUT)	V _{CC}	= 5 V ± ().5 V	V _{CC} =	3.3 V ±	0.3 V	V _{CC} =	2.7 V	UNIT
		(0011 01)	MIN	TYP	MAX	MIN	TYP	MAX	∠ MIN	MAX	
t _{pd}	Α	Υ		7	13	0.4	9	16	, N	18	ns
t _{en}	ŌĒ	Υ		11	18	JIE.	14	24	ALE.	28	ns
^t dis	ŌĒ	Y		12	23	(V	14	24		25	ns

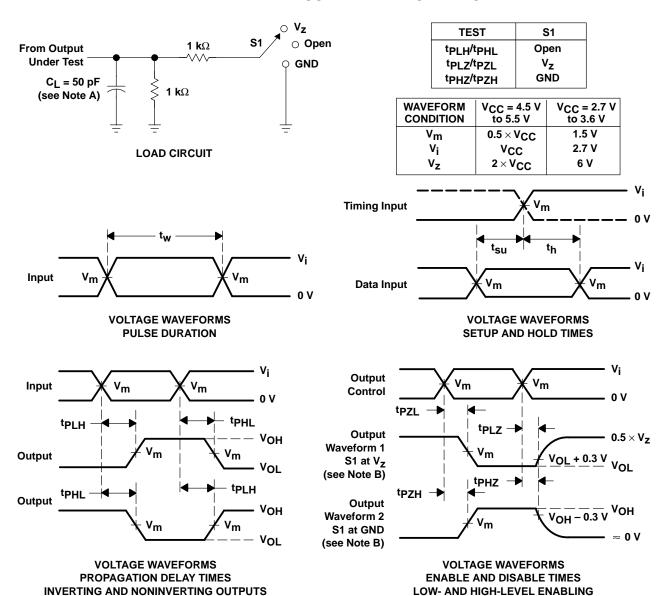
switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER						SN74L	.V240				
	FROM (INPUT)	TO (OUTPUT)	VCC:	= 5 V ± 0).5 V	VCC =	3.3 V \pm	0.3 V	VCC =	2.7 V	UNIT
	(1141 01)	(001101)	MIN	TYP	MAX	MIN	TYP	MAX	MIN	MAX	
t _{pd}	А	Y		7	13		9	16		18	ns
t _{en}	ŌĒ	Υ		11	18		14	24		28	ns
^t dis	ŌĒ	Y		12	23		14	24		25	ns

operating characteristics, V_{CC} = 3.3 V, T_A = 25°C

PARAMETER			TEST CONDITIONS	VCC	TYP	UNIT
C _{pd} Power dissipation capacitance per buffer/driver	Outputs enabled		3.3 V	45	pF	
	Outputs disabled	$C_1 = 50 \text{ pF}, f = 10 \text{ MHz}$		2.5		
	i ower dissipation capacitance per buner/unver	Outputs enabled	OL = 30 pr, 1 = 10 WHZ	5 V	78	Pi
		Outputs disabled			3	

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tplH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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